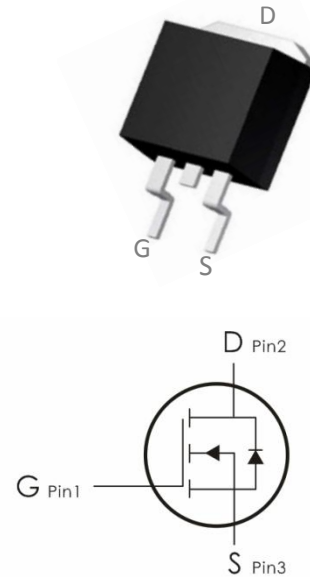


Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=80V, I_D=90A, R_{DS(ON)} < 8.5m\ \Omega @ V_{GS}=10V$ (Typ: $6.5m\ \Omega$)
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(ON)}$.
- 5) Excellent package for good heat dissipation.



Package Marking and Ordering Information:

Part NO.	Marking	Package	Packing
BG8R5NFG	G8R5NF	TO- 263	800 pcs/Reel

Absolute Maximum Ratings: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	80	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current ¹	90	A
	Continuous Drain Current ($T_C=100^\circ\text{C}$) ¹	63	
I_{DM}	Pulsed Drain Current ²	360	
P_D	Power Dissipation	170	W
E_{AS}	Single pulse avalanche energy ³	550	mJ
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55-+150	$^\circ\text{C}$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.88	$^\circ\text{C}/\text{W}$

Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu\text{A}$	80	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=80V$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics						
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu\text{A}$	2	3	4	V
$R_{DS(on)}$	Drain-Source On Resistance ⁴	$V_{GS}=10V, I_D=20A$	---	6.5	8.5	$\text{m}\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$	---	4800	---	pF
C_{oss}	Output Capacitance		---	662	--	
C_{rss}	Reverse Transfer Capacitance		---	430	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=30V, I_D=42A$ $R_{ENG}=10\ \Omega, V_{GS}=10V$	---	37.9	---	ns
t_r	Rise Time		---	57	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	89	---	ns
t_f	Fall Time		---	39	---	ns
Q_g	Total Gate Charge	$V_{DS}=48V, I_D=84A$	---	90	---	nC
Q_{gs}	Gate-Source Charge	$V_{GS}=10V$	---	24	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	32.7	---	nC
Drain-Source Diode Characteristics						
V_{SD}	Diode Forward Voltage	$V_{GS}=0V, I_{SD}=20A$	---	---	1.2	V
I_S	Continuous Drain Current	$V_D=V_G=0V$	---	---	75	A
I_{SM}	Pulsed Drain Current		---	---	300	A
T_{rr}	Reverse Recovery Time	$I_F=84A,$	---	88.3	---	ns
Q_{rr}	Reverse Recovery Charge	$dI/dt=100A/\mu\text{s}$	---	65.9	---	nC

Notes:

1. Computed continuous current assumes the condition of $T_{j,Max}$ while the actual continuous current depends on the thermal & electro-mechanical application board design
2. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
3. EAS condition : $T_J=25^{\circ}C, V_{DD}=40V, V_G=10V, L=0.5mH$
4. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$

Test Circuit

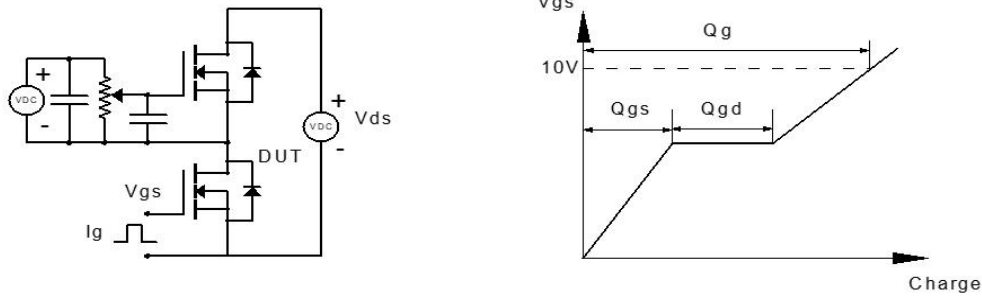


Figure 1: Gate Charge Test Circuit & Waveform

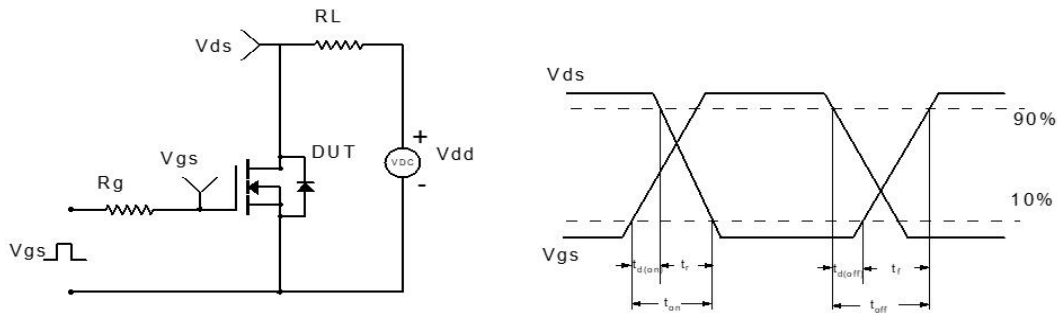


Figure 2: Resistive Switching Test Circuit & Waveform

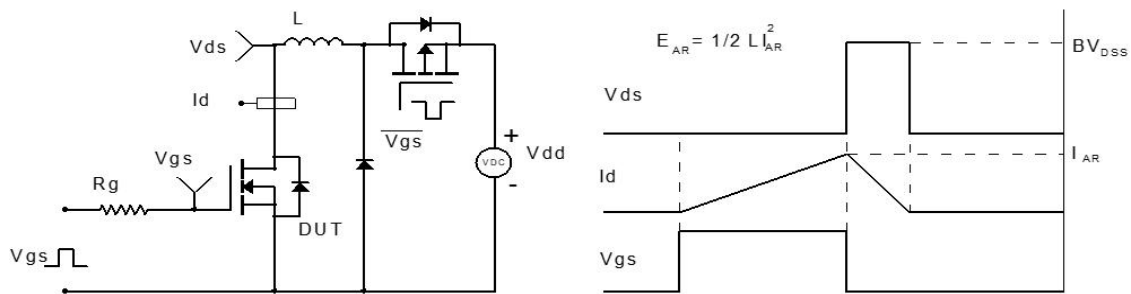


Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

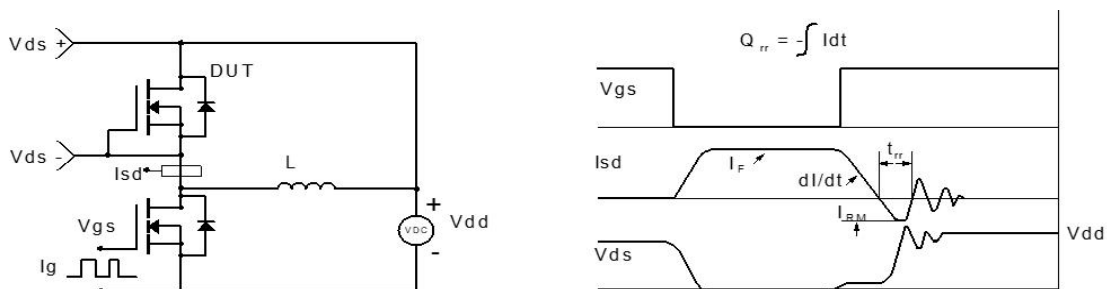
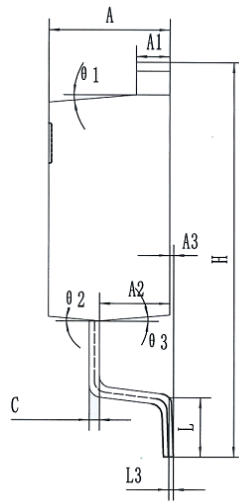
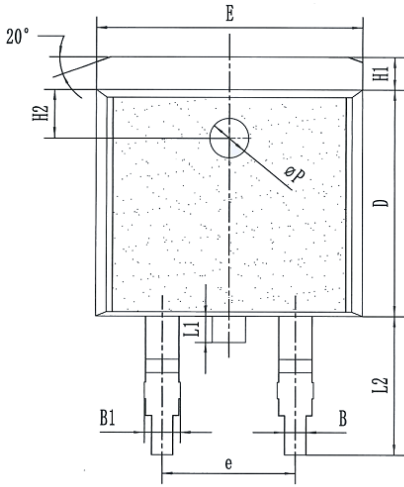


Figure 4: Diode Recovery Test Circuit & Waveform

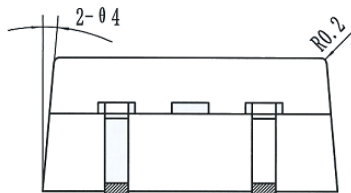
TO-263 Package Information: Unit:mm

Package Outline Type-A

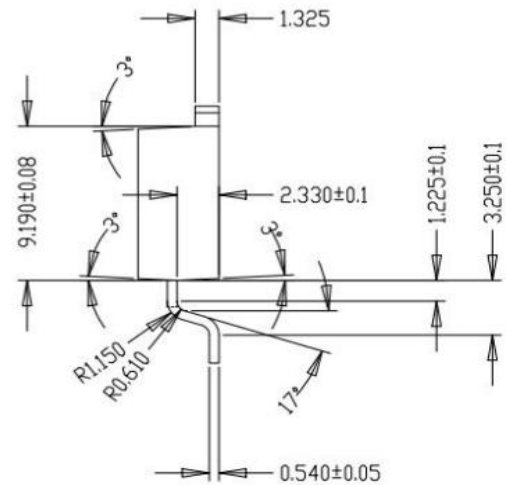
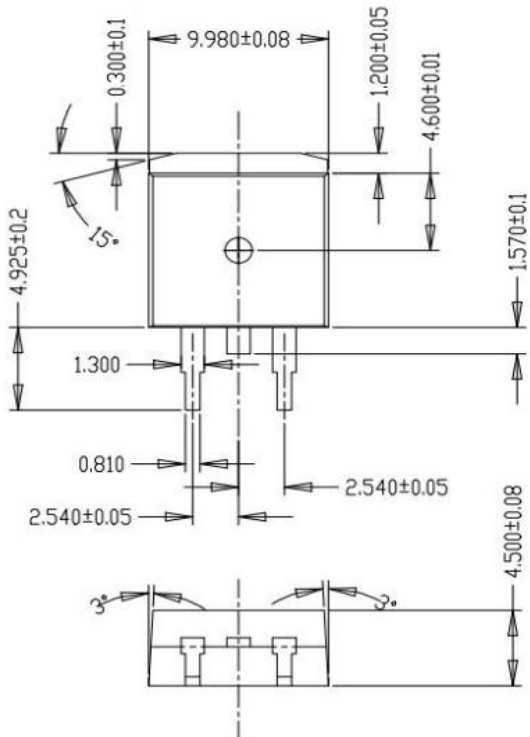


COMMON DIMENSIONS

SYMBOL	MM		
	MIN	NOM	MAX
A	4.50	4.60	4.70
A1	1.22	1.27	1.32
A2	2.57	2.67	2.77
A3	0.00		0.15
B	0.76	0.81	0.87
B1	1.32	1.37	1.42
C	0.33	0.38	0.43
D	8.55	8.65	8.75
e	5.08 BSC		
E	10.06	10.16	10.26
H	14.80	15.00	15.20
H1	1.17	1.27	1.37
H2	1.85 REF		
L	2.09	2.39	2.69
L1	0.80	1.00	1.20
L2	4.88	5.08	5.28
L3	0.25 REF		
φP	1.40	1.50	1.60
θ1	3°	5°	7°
θ2	3°	5°	7°
θ3	3°	5°	7°
θ4	3°	5°	7°

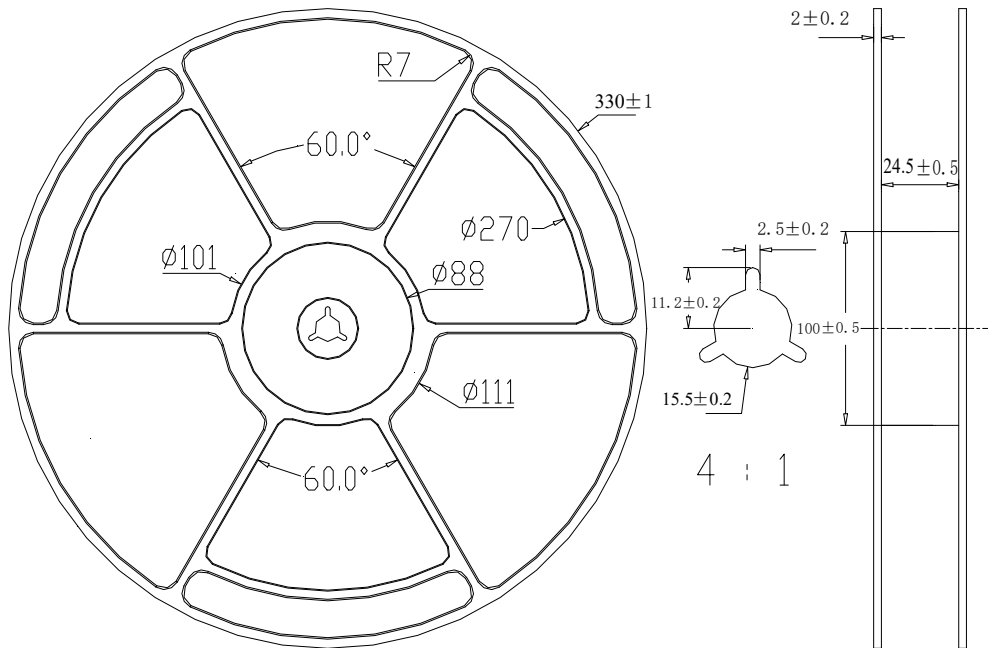


Package Outline Type-B

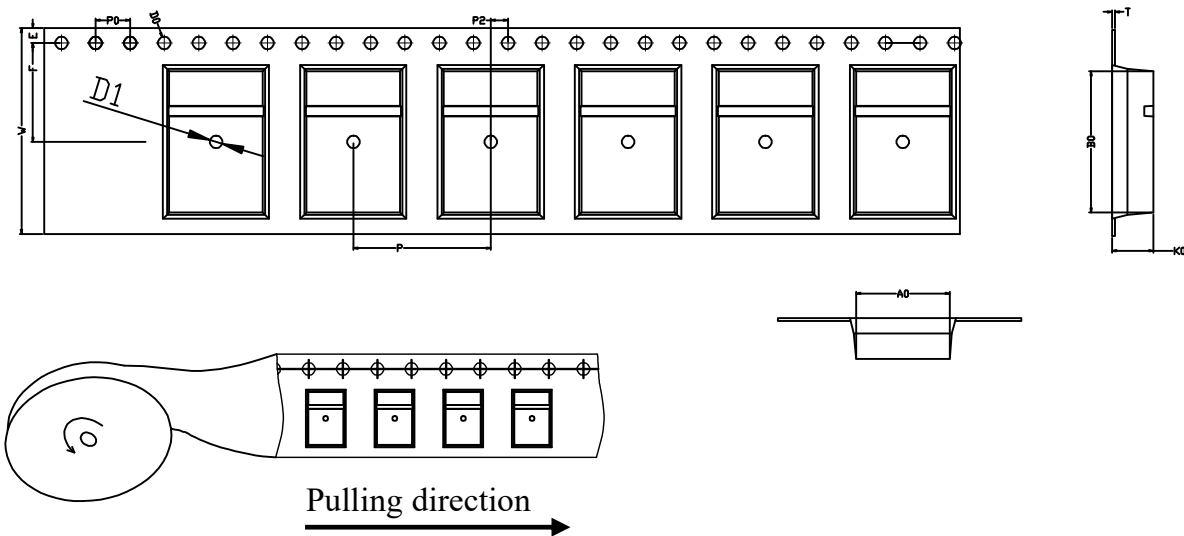


Tape & Reel Information

Dimensions in mm



ITEM	W	A0	B0	K0	S0	E	F	D0	D1
DIM	24	10.9	16.45	4.8	/	1.75	11.5	1.5	1.5
TOLR	+0.10 -0.10	+0.10 -0.10	+0.10 -0.10	+0.10 -0.10	+0.10 -0.10	+0.10 -0.10	+0.10 -0.10	+0.16 -0.00	+0.10 -0.10



Marking Information:

①. Doingter LOGO

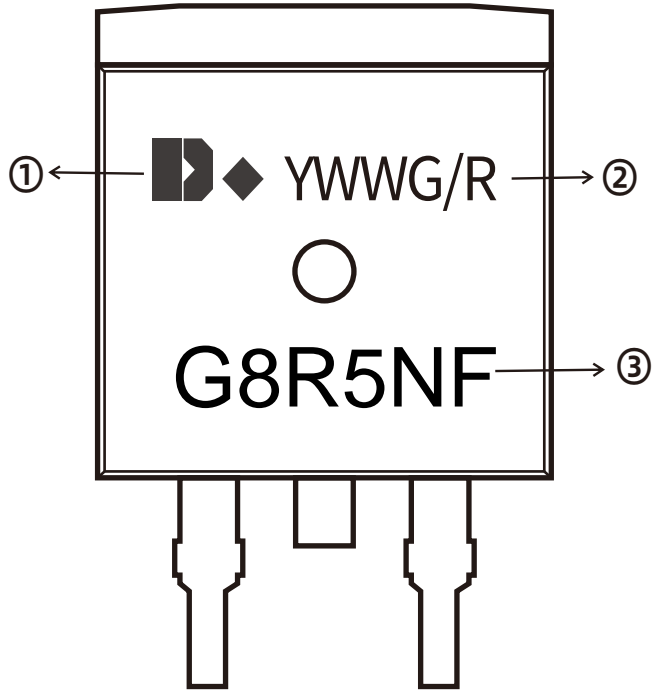
②. Date Code(YWWG / R)

Y : Year Code , last digit of the year

WW : Week Code(01-53)

G/R : G(Green) /R(Lead Free)

③. Part NO.



Previous Version

Version	Date	Subjects (major changes since last revision)
1.0	2025-12-01	Release of final version

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